

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination ADIFON ET AL.	
		Examiner Eric Pico	Art Unit 3654	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0087399	04-2005	Miyoshi et al.	187/254
*	B	US-2,184,205	12-1939	WEIKEL HARLEY E	217/56
*	C	US-6,405,834	06-2002	Chida et al.	187/391
*	D	US-5,271,455	12-1993	Semple, J. Brooks	165/80.4
*	E	US-6,305,499	10-2001	Jones et al.	187/261
*	F	US-4,526,252	07-1985	Hirano, Yasutaka	187/254
*	G	US-4,953,731	09-1990	Thornton et al.	217/56
*	H	US-5,644,111	07-1997	Cerny et al.	187/393
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000177949 A	06-2000	Japan	TADOKORO et al.	
	O	JP 07097157 A	04-1995	Japan	ONISHI, KIHACHIRO	
	P	EP 646537 A1	04-1995	European Patent	HAKOLA, PEKKA	
	Q	JP 2001039642 A	02-2001	Japan	MIYOSHI et al.	
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author; Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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